Application/Control No. Applicant(s)/Patent Under Reexamination 10/601,996 PFEIFER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Mylinh Tran 2179 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 08-2005 US-6,928,474 Venkatesan, Thyagarajan 709/224 Α * US-2003/0229537 12-2003 705/10 В Dunning et al. US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

X

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.